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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Atty. Docket:

O'Neill *et al.*

03W179

Serial No.: 10/790,894

Art Unit: 2878

Filed: March 1, 2004

Examiner: Wyatt, Kevin S.

Customer No.: 7590

Confirmation No.: 2583

Title: Method for Analyzing Output Data of Array Subelements of an Imaging Segmented Array

RESPONSE

Mail Stop AF
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This paper is herewith filed in response to the Examiner's Office Action mailed on February 25, 2009 (hereinafter "the February 25 Office Action") for the above-captioned U.S. Patent Application. Applicants believe that there are no fees due at this time. If there are further fees due to maintain the pendency of this application, charge them to deposit account no. 50-1924.

A Listing of Claims begins on page 2 of this paper.

Remarks begin on page 11 of this paper.